

Home | Login | Logical | Access Information | Alers | Purchase Highey | SEARCH

Welcome United States Paters and Trademark Office

Advanced Search SROWSE

OPTION 1 (2) Help Enter keywords or phrases, select fields, and select operators in All Fields. AND * in All Fields. AND ₩ in All Fields » Note: If you use all three search boxes, the entries in the first two boxes take precedence over the entry in the third box. OPTION 2 (2) Help Enter keywords, phrases, or a Boolean expression

- (CT or volume or tomograph* or voxel) <paragraph> ((seed or region) <near/5> grow*) <paragraph> ((distance or depth) <near/5> (transform* or map))
- » Note: You may use the search operators <and> or <or> without the start and end brackets <>.
- » Learn more about Field Codes, Search Examples, and Search Operators

.. Publications

Select publications

REEE XPLORE GUIDE

- IEEE Periodicals
- IET Periodicals
- AIP/AVS Periodica
- IEEE Conference I IET Conference Pr
- IEEE Standards

» Other Resources (Availab

- IEEE Books
- Educational Courses

» Standard Status (Applies to IEEE Standards

Status All ٠

. Select date range

- C Search latest content u
- From year All to Present w

Citatio

» Display Format

Citation

- Organize results

Maximum 100 * Display 25 * resu Sort by Relevance

In Descending

Help Contact Us @ Copyright 20

